

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/561,144	SHIMOMURA ET AL.	
	Examiner Jae W. Lee, Ph.D.	Art Unit 1656	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	WO/2000/21990	04-2000		Jacobs et al.	
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NON-PATENT DOCUMENTS

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